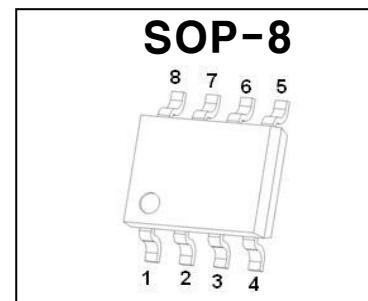


# P Channel MOS FET

$V_{(BR)DSS}$	$R_{DS(on)}\text{MAX}$	$I_D$
-20V	8.5mΩ@-4.5V	-14A
	12mΩ@-2.5V	
	15mΩ@-1.8V	



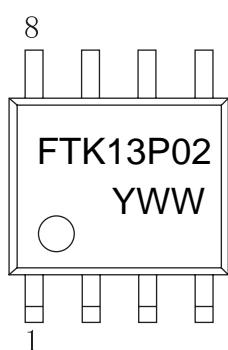
## FEATURE

- High Density Cell Design for Ultra Low Rdson
- Fully Characterized Avalanche Voltage and Current
- Good Stability and Uniformity With High E<sub>AS</sub>
- Excellent Package for Good Heat Dissipation

## APPLICATION

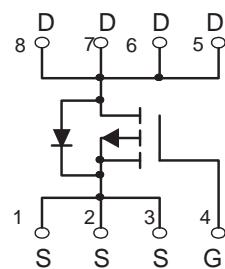
- Load Switch
- Battery Protection

## MARKING



FTK13P02 = Device code  
Solid dot = Pin1 indicator  
YWW = Date Code

## Equivalent Circuit



## ABSOLUTE MAXIMUM RATINGS ( $T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	- 20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current	$I_D$	-14	A
Pulsed Drain Current (note 1)	$I_{DM}$	-56	A
Power Dissipation	$P_D$	1.4	W
Thermal Resistance, Junction-to-ambient(note 2)	$R_{\theta JA}$	89.29	°C/W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~+150	°C

**MOSFET ELECTRICAL CHARACTERISTICS**
**T<sub>a</sub>=25°C unless otherwise specified**

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static characteristics</b>						
Drain-source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =-250uA	-20	---	---	V
BVDSS temperature coefficient	Δ BV <sub>DSS</sub> / Δ T <sub>J</sub>	Reference to 25°C, I <sub>D</sub> =-1mA	---	-0.01	---	V/°C
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-0.3	-0.6	-1.0	V
Drain-source leakage current	I <sub>DSS</sub>	V <sub>DS</sub> =-20 V, V <sub>GS</sub> =0V, T <sub>J</sub> = 25°C	---	---	-1	μA
		V <sub>DS</sub> =-16 V, V <sub>GS</sub> =0V, T <sub>J</sub> = 125°C	---	---	-10	μA
Gate leakage current, Forward	I <sub>GSSF</sub>	V <sub>GS</sub> =12 V, V <sub>DS</sub> =0 V	---	---	100	nA
Gate leakage current, Reverse	I <sub>GSSR</sub>	V <sub>GS</sub> =-12 V, V <sub>DS</sub> =0 V	---	---	-100	nA
Drain-source on-state resistance	R <sub>DSS(on)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A	---	6.5	8.5	mΩ
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-8A	---	9	12	mΩ
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-5A	---	12	15	mΩ
Forward transconductance	g <sub>f</sub>	V <sub>DS</sub> =-10V , I <sub>D</sub> =-5A	---	20	---	S
<b>Dynamic characteristics</b>						
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0 V, F = 1MHz	---	4060	8000	pF
Output capacitance	C <sub>oss</sub>		---	520	1000	
Reverse transfer capacitance	C <sub>rss</sub>		---	400	800	
Turn-on delay time <sup>(note 2,3)</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> = -10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> = -1A R <sub>G</sub> = 25Ω	---	13.2	26	ns
Rise time <sup>(note 2,3)</sup>	t <sub>r</sub>		---	68	120	
Turn-off delay time <sup>(note 2,3)</sup>	t <sub>d(off)</sub>		---	160	320	
Fall time <sup>(note 2,3)</sup>	t <sub>f</sub>		---	154	300	
<b>Gate charge characteristics</b>						
Gate to source charge <sup>(note 2,3)</sup>	Q <sub>gs</sub>	V <sub>DS</sub> =-10 V, I <sub>D</sub> =-5A, V <sub>GS</sub> = -4.5 V	---	7.2	14	nC
Gate to drain charge <sup>(note 2,3)</sup>	Q <sub>gd</sub>		---	10.2	20	
Gate charge total <sup>(note 2,3)</sup>	Q <sub>g</sub>		---	44.4	80	
<b>Drain-Source diode characteristics and Maximum Ratings</b>						
Continuous Source Current	I <sub>S</sub>	V <sub>G</sub> =V <sub>D</sub> =0 V, Force Current	---	---	-14	A
Pulsed Source Current	I <sub>SM</sub>		---	---	-28	A
Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A, T <sub>J</sub> =25°C	---	---	-1	V

**Notes:**

1: Repetitive Rating: Pulse width limited by maximum junction temperature.

2: Pulse Test : Pulse Width ≤ 300μ s, Duty Cycle≤ 2%.

3: Essentially independent of operating temperature.

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1. Continuous Drain Current vs.  $T_c$

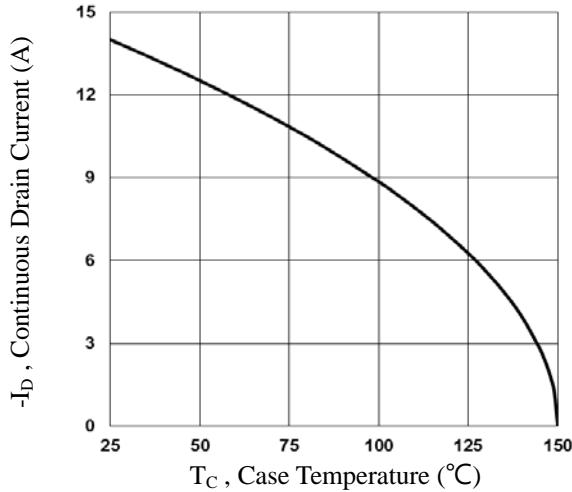


Figure 2. Normalized RDSON vs.  $T_J$

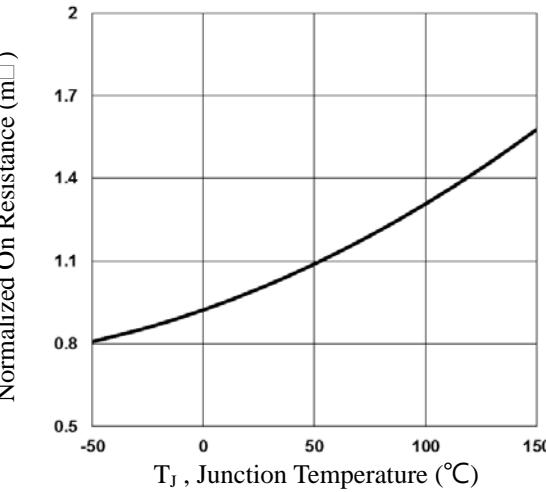


Figure 3. Normalized  $V_{th}$  vs.  $T_J$

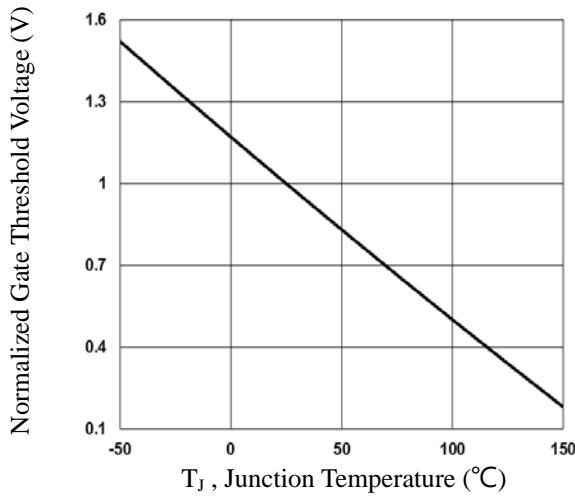


Figure 4. Gate Charge Waveform

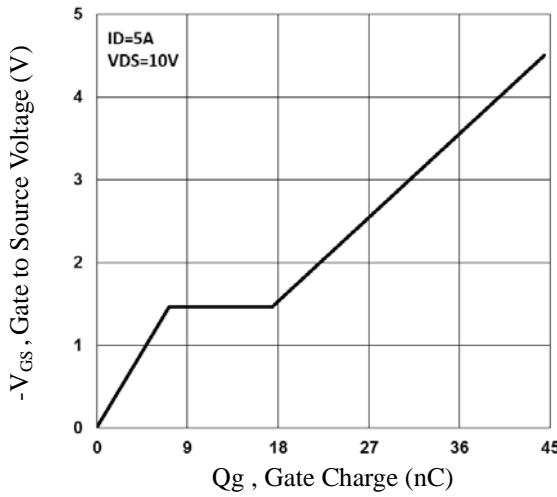


Figure 5. Normalized Transient Impedance

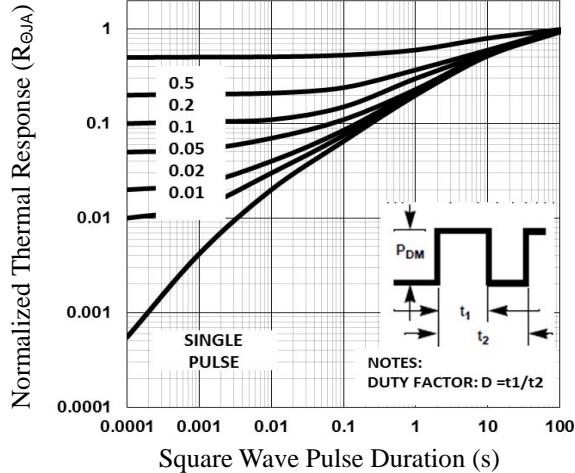
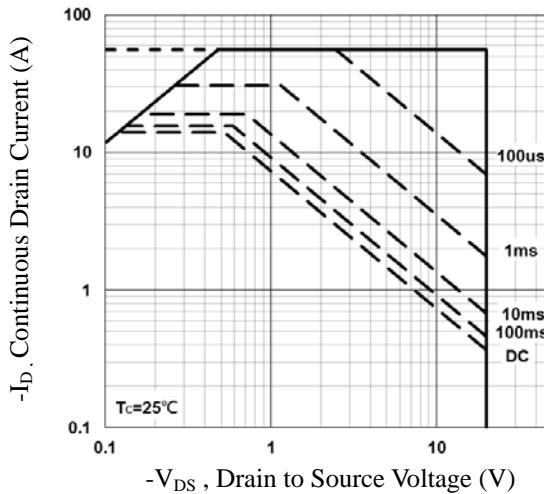
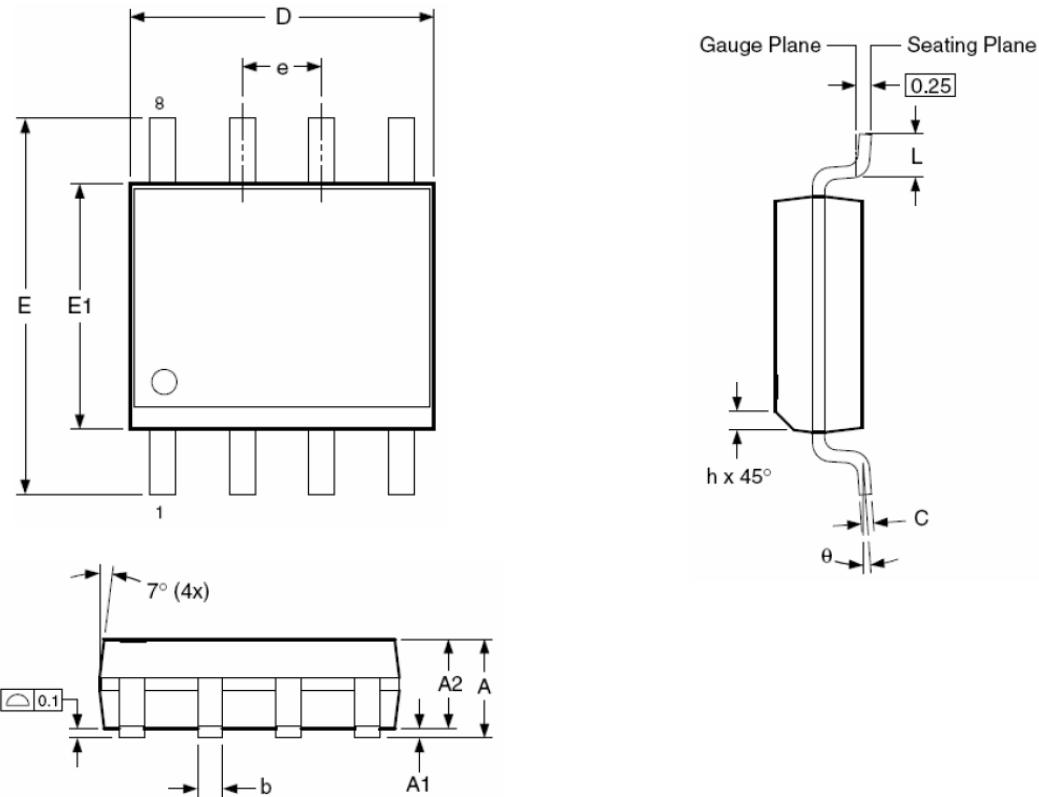


Figure 6. Maximum Safe Operation Area

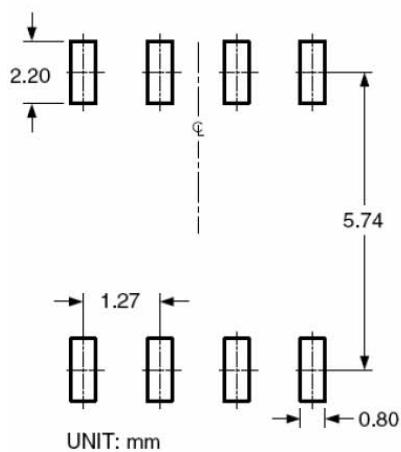


## SOP-8 PACKAGE INFORMATION

Dimensions in Millimeters (UNIT:mm)



### RECOMMENDED LAND PATTERN



### Dimensions in millimeters

Symbols	Min.	Nom.	Max.
A	1.35	1.65	1.75
A1	0.10	—	0.25
A2	1.25	1.50	1.65
b	0.31	—	0.51
c	0.17	—	0.25
D	4.80	4.90	5.00
E1	3.80	3.90	4.00
e	1.27 BSC		
E	5.80	6.00	6.20
h	0.25	—	0.50
L	0.40	—	1.27
θ	0°	—	8°

### Dimensions in inches

Symbols	Min.	Nom.	Max.
A	0.053	0.065	0.069
A1	0.004	—	0.010
A2	0.049	0.059	0.065
b	0.012	—	0.020
c	0.007	—	0.010
D	0.189	0.193	0.197
E1	0.150	0.154	0.157
e	0.050 BSC		
E	0.228	0.236	0.244
h	0.010	—	0.020
L	0.016	—	0.050
θ	0°	—	8°

### NOTES:

1. All dimensions are in millimeters.
2. Dimensions are inclusive of plating.
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.